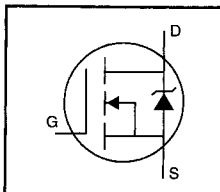


**HEXFET® Power MOSFET**

- Surface Mount
- Available in Tape & Reel
- Dynamic  $dv/dt$  Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements



$$V_{DSS} = 250V$$

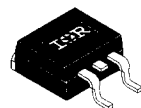
$$R_{DS(on)} = 0.28\Omega$$

$$I_D = 14A$$

**Description**

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.



SMD-220

**Absolute Maximum Ratings**

|                             | Parameter                                 | Max.                  | Units |
|-----------------------------|-------------------------------------------|-----------------------|-------|
| $I_D$ @ $T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS}$ @ 10 V | 14                    | A     |
| $I_D$ @ $T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS}$ @ 10 V | 8.5                   |       |
| $I_{DM}$                    | Pulsed Drain Current ①                    | 56                    |       |
| $P_D$ @ $T_C = 25^\circ C$  | Power Dissipation                         | 125                   | W     |
| $P_D$ @ $T_A = 25^\circ C$  | Power Dissipation (PCB Mount)**           | 3.1                   |       |
|                             | Linear Derating Factor                    | 1.0                   | W/°C  |
|                             | Linear Derating Factor (PCB Mount)**      | 0.025                 |       |
| $V_{GS}$                    | Gate-to-Source Voltage                    | $\pm 20$              | V     |
| $E_{AS}$                    | Single Pulse Avalanche Energy ②           | 550                   | mJ    |
| $I_{AR}$                    | Avalanche Current ①                       | 14                    | A     |
| $E_{AR}$                    | Repetitive Avalanche Energy ①             | 13                    | mJ    |
| $dv/dt$                     | Peak Diode Recovery $dv/dt$ ③             | 4.8                   | V/ns  |
| $T_J, T_{STG}$              | Junction and Storage Temperature Range    | -55 to +150           | °C    |
|                             | Soldering Temperature, for 10 seconds     | 300 (1.6mm from case) |       |

**Thermal Resistance**

|                 | Parameter                         | Min. | Typ. | Max. | Units |
|-----------------|-----------------------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                  | —    | —    | 1.0  | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB mount)** | —    | —    | 40   |       |
| $R_{\theta JA}$ | Junction-to-Ambient               | —    | —    | 62   |       |

\*\* When mounted on 1" square PCB (FR-4 or G-10 Material).

For recommended footprint and soldering techniques refer to application note #AN-994.

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

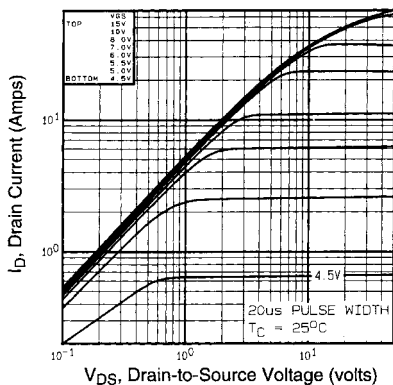
|                                 | Parameter                            | Min. | Typ. | Max. | Units            | Test Conditions                                                     |
|---------------------------------|--------------------------------------|------|------|------|------------------|---------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 250  | —    | —    | V                | $V_{GS}=0V, I_D=250\mu A$                                           |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.34 | —    | $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D=1\text{mA}$                  |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.28 | $\Omega$         | $V_{GS}=10V, I_D=8.4A$ ④                                            |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —    | 4.0  | V                | $V_{DS}=V_{GS}, I_D=250\mu A$                                       |
| $g_{fs}$                        | Forward Transconductance             | 6.7  | —    | —    | S                | $V_{DS}=50V, I_D=8.4A$ ④                                            |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25   | $\mu A$          | $V_{DS}=250V, V_{GS}=0V$                                            |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA               | $V_{DS}=200V, V_{GS}=0V, T_J=125^\circ\text{C}$                     |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 | nA               | $V_{GS}=-20V$                                                       |
| $Q_g$                           | Total Gate Charge                    | —    | —    | 68   | nC               | $I_D=7.9A$                                                          |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —    | 11   | nC               | $V_{DS}=200V$                                                       |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —    | 35   | nC               | $V_{GS}=10V$ See Fig. 6 and 13 ④                                    |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 11   | —    | ns               | $V_{DD}=125V$                                                       |
| $t_r$                           | Rise Time                            | —    | 24   | —    | ns               | $I_D=7.9A$                                                          |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 53   | —    | ns               | $R_G=9.1\Omega$                                                     |
| $t_f$                           | Fall Time                            | —    | 49   | —    | ns               | $R_D=8.7\Omega$ See Figure 10 ④                                     |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5  | —    | nH               | Between lead, 6 mm (0.25in.) from package and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 7.5  | —    | nH               |                                                                     |
| $C_{iss}$                       | Input Capacitance                    | —    | 1300 | —    | pF               | $V_{GS}=0V$                                                         |
| $C_{oss}$                       | Output Capacitance                   | —    | 330  | —    | pF               | $V_{DS}=25V$                                                        |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 85   | —    | pF               | $f=1.0\text{MHz}$ See Figure 5                                      |

## Source-Drain Ratings and Characteristics

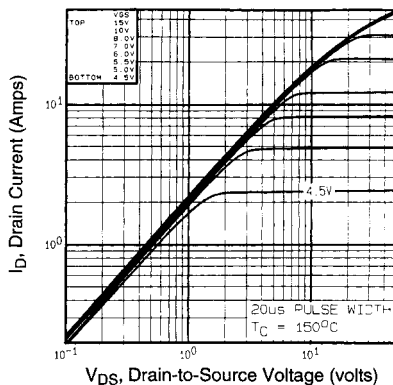
|          | Parameter                              | Min.                                                                      | Typ. | Max. | Units   | Test Conditions                                                |
|----------|----------------------------------------|---------------------------------------------------------------------------|------|------|---------|----------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —                                                                         | —    | 14   | A       | MOSFET symbol showing the integral reverse p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —                                                                         | —    | 56   | A       |                                                                |
| $V_{SD}$ | Diode Forward Voltage                  | —                                                                         | —    | 1.8  | V       | $T_J=25^\circ\text{C}, I_S=14A, V_{GS}=0V$ ④                   |
| $t_{rr}$ | Reverse Recovery Time                  | —                                                                         | 250  | 500  | ns      | $T_J=25^\circ\text{C}, I_F=7.9A$                               |
| $Q_{rr}$ | Reverse Recovery Charge                | —                                                                         | 2.3  | 4.6  | $\mu C$ | $di/dt=100A/\mu s$ ④                                           |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ ) |      |      |         |                                                                |

### Notes:

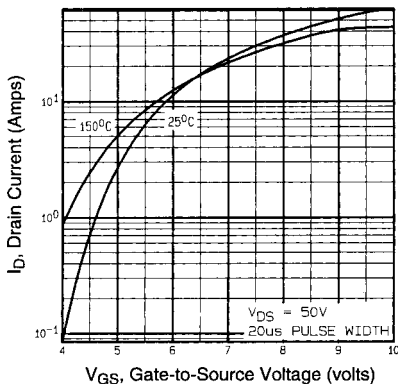
- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ②  $V_{DD}=50V$ , starting  $T_J=25^\circ\text{C}$ ,  $L=4.5\text{mH}$   
 $R_G=25\Omega$ ,  $I_{AS}=14A$  (See Figure 12)
- ③  $I_{SD}\leq 14A$ ,  $di/dt\leq 150A/\mu s$ ,  $V_{DD}\leq V_{(BR)DSS}$ ,  
 $T_J\leq 150^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .



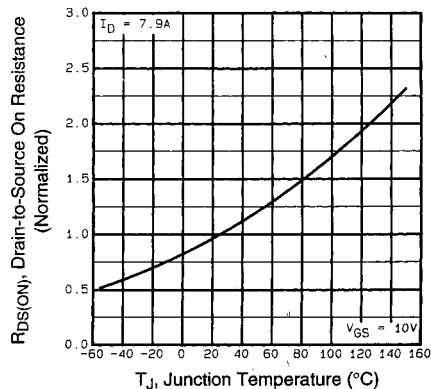
**Fig 1.** Typical Output Characteristics,  
 $T_C=25^\circ\text{C}$



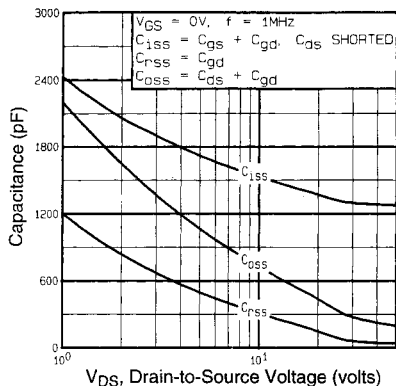
**Fig 2.** Typical Output Characteristics,  
 $T_C=150^\circ\text{C}$



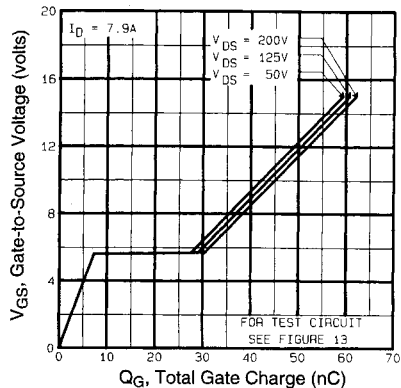
**Fig 3.** Typical Transfer Characteristics



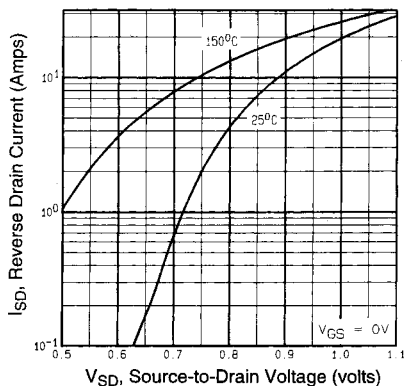
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



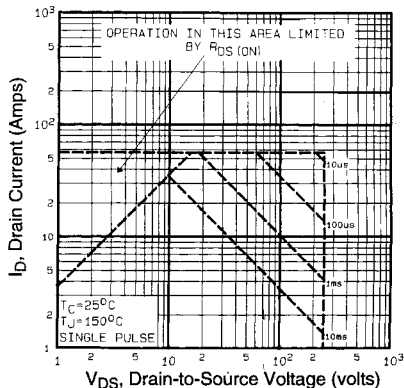
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



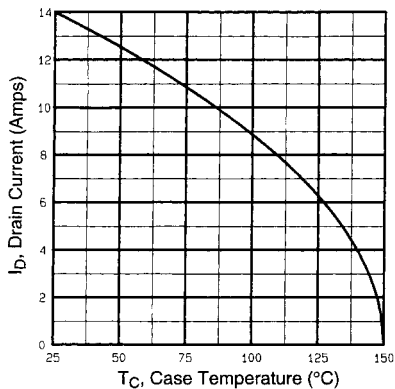
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



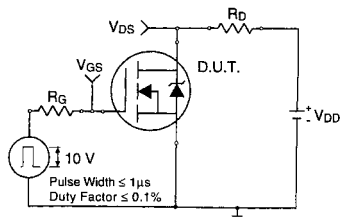
**Fig 7.** Typical Source-Drain Diode Forward Voltage



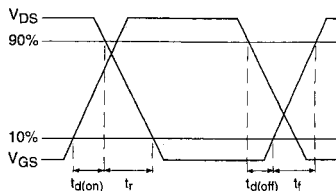
**Fig 8.** Maximum Safe Operating Area



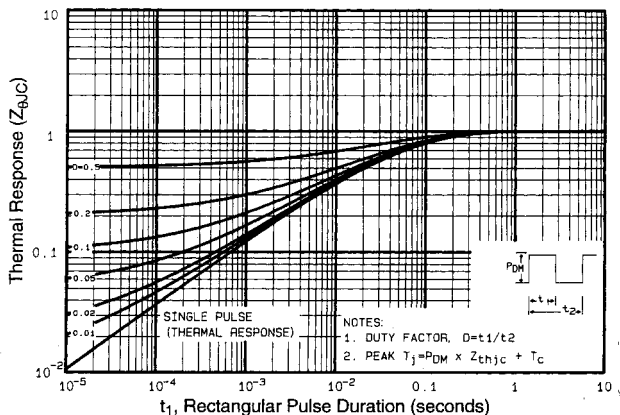
**Fig 9.** Maximum Drain Current Vs. Case Temperature



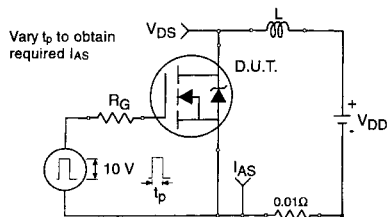
**Fig 10a.** Switching Time Test Circuit



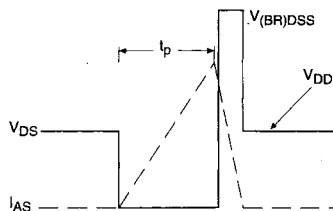
**Fig 10b.** Switching Time Waveforms



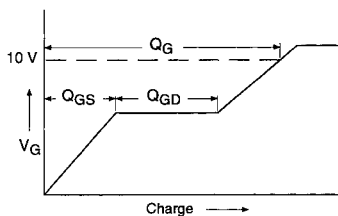
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



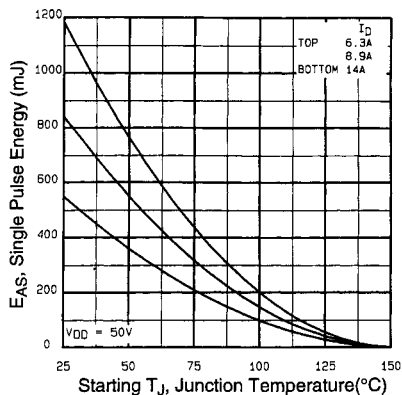
**Fig 12a.** Unclamped Inductive Test Circuit



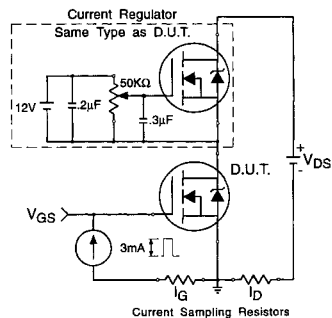
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 13a.** Basic Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13b.** Gate Charge Test Circuit

**Appendix A:** Figure 14, Peak Diode Recovery  $dv/dt$  Test Circuit

**Appendix B:** Package Outline Mechanical Drawing

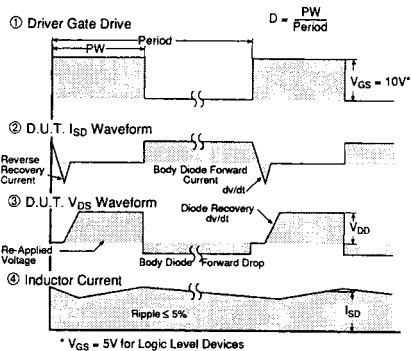
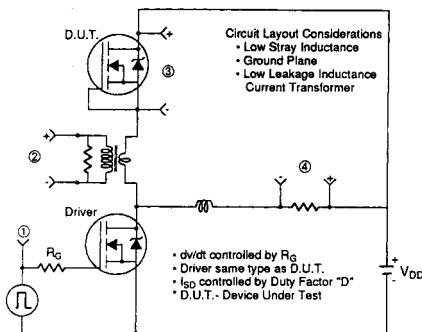
**Appendix C:** Part Marking Information

**Appendix D:** Tape & Reel Information

## Appendix A

## Peak Diode Recovery dv/dt Test Circuit

Fig 14. For N-Channel HEXFETs

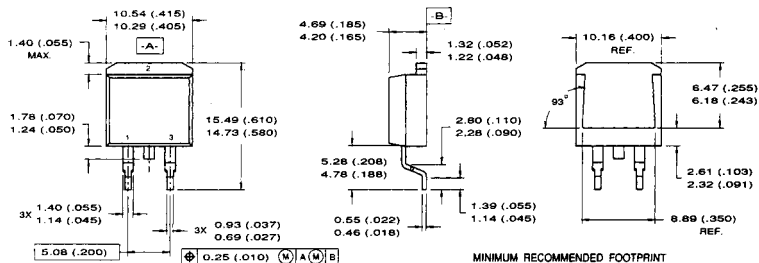


## Appendix B

## Package Outline

### SMD-220 Outline

Dimensions are shown in millimeters (inches)



#### NOTES:

1. DIMENSIONS AFTER SOLDER DIP.
2. DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982
3. CONTROLLING DIMENSION: INCH.
4. HEATSINK & LEAD DIMENSIONS DO NOT INCLUDE BURRS.

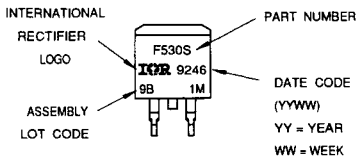
#### LEAD ASSIGNMENTS

1. GATE
2. DRAIN
3. SOURCE

## Part Marking Information

### SMD-220

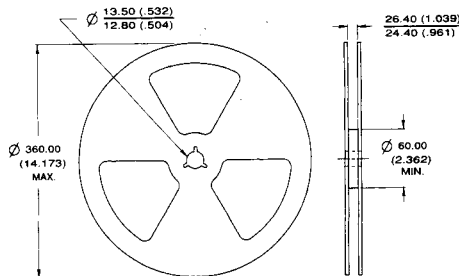
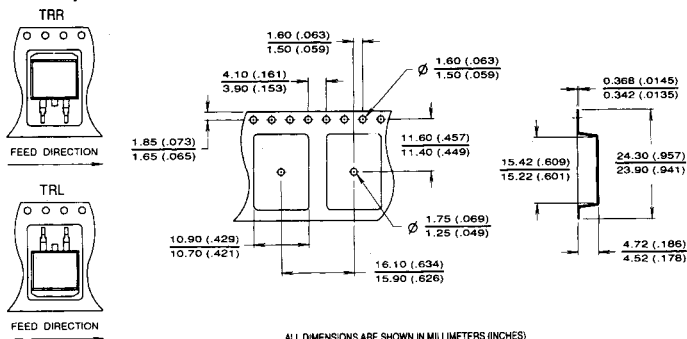
EXAMPLE: THIS IS AN IRF530S WITH  
ASSEMBLY LOT CODE 9B1M



## Appendix C

## Tape & Reel Information

### SMD-220 Tape & Reel



### SMD-220 Tape & Reel

When ordering, indicate the part number, part orientation, and the quantity. Quantities are in multiples of 800 pieces per reel for both TRL and TRR.



Printed on Signet recycled offset:  
made from 50% recycled waste paper, including  
10% de-inked, post-consumer waste.



**International**  
**IR Rectifier**

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